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PATENT Attorney Docket No. 5168-74

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

n re Application of:	
Kazuaki Yoshida)	Group Art Unit: To be Assigned
Application No.: 10/593,147	Examiner: To be Assigned
Filed: September 18, 2006	
For: Polishing Composition and) Polishing Method)	Confirmation No.: To be Assigned
Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450	
Sir:	

INFORMATION DISCLOSURE STATEMENT

Enclosed for the consideration of the Examiner in connection with the prosecution of this case is a copy of six published Japanese patent applications and article set forth on the attached Form PTO/SB/08. Please refer to the abstracts in English for the relevance of each of the Japanese applications.

If there is any fee due in connection with the filing of this Statement, please charge such fee to our deposit account 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW,

GABRETT & DUNNER, L.L.P.

Dated: December 14, 2006 By: (MMW X) / MWSC)

Arthur S. Garrett Reg. No. 20,338 Tel: 202 408 4091

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IDS Form PTO/SB/08: Substitute for form 1449A/PTO			С	omplete if Known	DEC 1 4 200	6	
				Application Number	10/593,147	13	نغ
INFO	DRMATION D	ISCLOSU	IRE	Filing Date	September 18, 2006	132	8/
STATEMENT BY APPLICANT			First Named Inventor	Kazuaki Yoshida	PADELLA	/	
			Art Unit	To be Assigned			
	(Use as many sheets	as necessary)		Examiner Name	To be Assigned		
Sheet	1	of	2	Attorney Docket Number	5168-74		

	U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS						
Examiner	Cite	1	Issue or	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where		
Initials I	No. ¹	Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY		Relevant Passages or Relevant Figures Appear		
		US-					
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Note: Submission of copies of U.S. Patents and published U.S. Patent Applications is not required.

FOREIGN PATENT DOCUMENTS							
Examiner Initials	Cite No.1	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures	Translation ⁶	
		Country Code ³ Number ⁴ Kind Code ⁵ (<i>if known</i>)]		Appear		
/J.H./		JP 2000-8024	01-11-2000	Tanaka Hiroaki		X-Abstract	
/J.H./		JP 2001-93866	04-06-2001	Speedfam Co. Ltd.		X-Abstract	
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NON PATENT LITERATURE DOCUMENTS						
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/J.H./		U. MAHAJAN ET AL., "Dynamic Lateral Force Measurements during Chemical Mechanical Polishing of Silica," Electrochemical and Solid-State Letters, 2 (2) 80-82 (1999)				
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Examiner Signature	/John Hevey/	Date Considered	04/28/2008
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